

NCEP1550JG-VB Datasheet

N-Channel 150 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$ Max.	I _D (A) ^g	Q _g (Typ.)			
150	0.0158 at V _{GS} = 10 V	53.7	22.8 nC			
	0.0188 at V _{GS} = 7.5 V	45	22.0110			

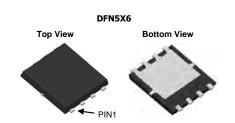
FEATURES

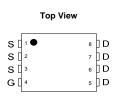
- TrenchFET[®] Power MOSFET
- 100 % R_q and UIS Tested

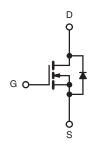


APPLICATIONS

- · Fixed Telecom
- DC/DC Converter
- Primary and Secondary Side Switch







N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS	S (T _A = 25 °C, unle	ess otherwise no	oted)		
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V_{DS}	150	V		
Gate-Source Voltage	V_{GS}	± 20			
	T _C = 25 °C		53.7		
Continuous Drain Current (T _{.I} = 150 °C)	T _C = 70 °C		43	A	
Continuous Diain Current (1) = 150 C)	T _A = 25 °C	I _D	12.8 ^{b, c}		
	T _A = 70 °C		10.2 ^{b, c}		
Pulsed Drain Current (t = 300 μs)		I _{DM}	130	A	
Continuous Source-Drain Diode Current	T _C = 25 °C	I _S	60 ^a		
Continuous Source-Diam Diode Current	T _A = 25 °C	'S	5.6 ^{b, c}		
Single Pulse Avalanche Current		I _{AS}	30		
Single Pulse Avalanche Energy	L = 0.1 mH	E _{AS}	45	mJ	
	T _C = 25 °C		104	- W	
Maximum Power Dissipation	T _C = 70 °C	P _D	66.6		
Maximum Fower Dissipation	T _A = 25 °C	L D	6.25 ^{b, c}		
	T _A = 70 °C		4 ^{b, c}		
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 150	°C		
Soldering Recommendations (Peak Temperature		260			

THERMAL RESISTANCE RATINGS							
Parameter	Symbol	Typical	Maximum	Unit			
Maximum Junction-to-Ambient ^{b, f}	t ≤ 10 s	R_{thJA}	15	20	°C/W		
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	0.9	1.2]		

Notes:

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s
- d. The DFN5x 6 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 54 °C/W.
- g. $T_C = 25$ °C.



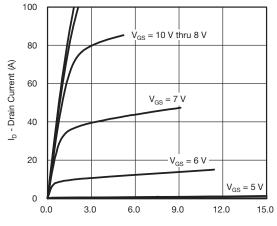
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	150			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J I _D = 250 μA		105		m\//°C
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_{J}$			- 9.4		mV/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2.0		4.0	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zara Cata Valtaga Drain Current		V _{DS} = 150 V, V _{GS} = 0 V			1	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 150 V, V _{GS} = 0 V, T _J = 70 °C			10	μΑ
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	40			Α
	_	$V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$		0.0158		
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 7.5 \text{ V}, I_D = 15 \text{ A}$		0.0188		Ω
Forward Transconductance ^a	9 _{fs}	$V_{DS} = 10 \text{ V}, I_{D} = 20 \text{ A}$		30		S
Dynamic ^b	l l			ı		·
Input Capacitance	C _{iss}			1286		pF
Output Capacitance	C _{oss}	$V_{DS} = 75 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		327		
Reverse Transfer Capacitance	C _{rss}			28		
Total Cata Charge	Qg	$V_{DS} = 75 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 20 \text{ A}$		31.3	47	nC
Total Gate Charge				22.8	35	
Gate-Source Charge	Q_{gs}	$V_{DS} = 75 \text{ V}, V_{GS} = 7.5 \text{ V}, I_{D} = 20 \text{ A}$		8		
Gate-Drain Charge	Q_gd			10		
Output Charge	Q _{oss}	V _{DS} = 75 V, V _{GS} = 0 V		66	100	
Gate Resistance	R_g	f = 1 MHz	0.3	1	2	Ω
Turn-On Delay Time	t _{d(on)}			10	20	
Rise Time	t _r	V_{DD} = 75 V, R_L = 3.75 Ω		12	24	
Turn-Off Delay Time	t _{d(off)}	$\rm I_D\cong 20$ A, $\rm V_{GEN}$ = 10 V, $\rm R_g$ = 1 Ω		15	30	
Fall Time	t _f			7	14	
Turn-On Delay Time	t _{d(on)}			12	24	ns
Rise Time	t _r	V_{DD} = 75 V, R_L = 3.75 Ω		13	26	
Turn-Off Delay Time	t _{d(off)}	$I_D\cong 20$ A, V_{GEN} = 7.5 V, R_g = 1 Ω		17	34	
Fall Time	t _f			8	16	
Drain-Source Body Diode Characteristic	s					
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			60	Α
Pulse Diode Forward Current ^a	I _{SM}				100	_ ^
Body Diode Voltage	V_{SD}	I _S = 5 A		0.77	1.1	V
Body Diode Reverse Recovery Time	t _{rr}			95	190	ns
Body Diode Reverse Recovery Charge	Q _{rr}			280	560	nC
Reverse Recovery Fall Time	t _a	$I_F = 20 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		72		
Reverse Recovery Rise Time	t _b			23		ns

Notes:

- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

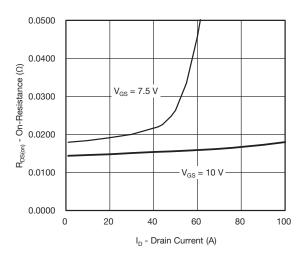
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



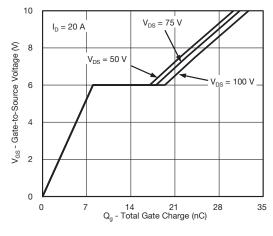


V_{DS} - Drain-to-Source Voltage (V)

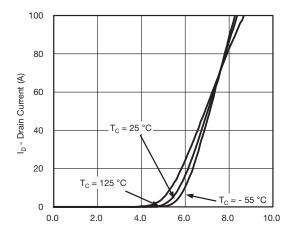
Output Characteristics



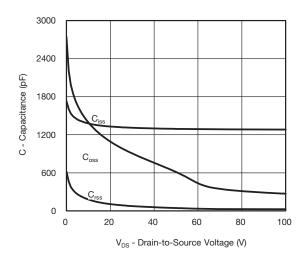
On-Resistance vs. Drain Current



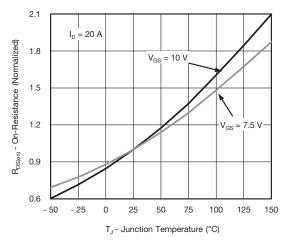
Gate Charge



V_{GS} - Gate-to-Source Voltage (V) **Transfer Characteristics**

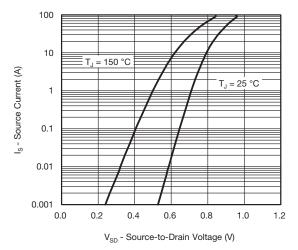


Capacitance

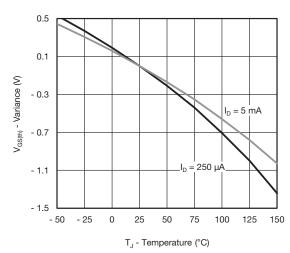


On-Resistance vs. Junction Temperature

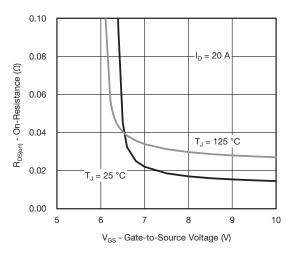




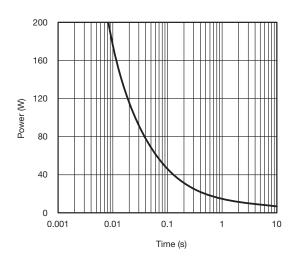
Source-Drain Diode Forward Voltage



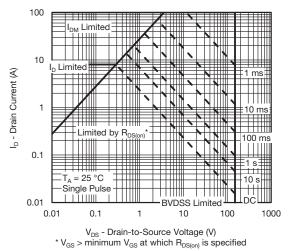
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage

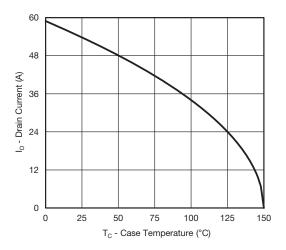


Single Pulse Power, Junction-to-Ambient

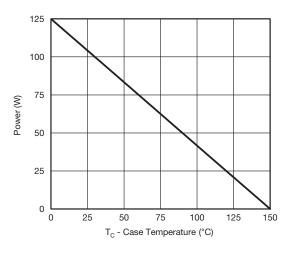


Safe Operating Area, Junction-to-Ambient

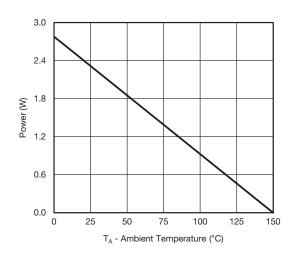




Current Derating*



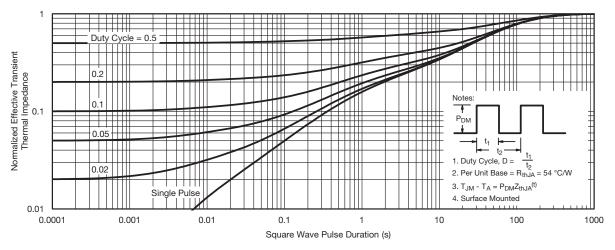




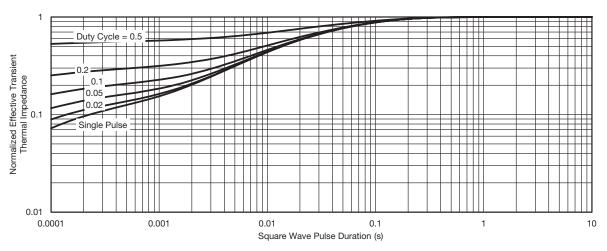
Power, Junction-to-Ambient

^{*} The power dissipation P_D is based on $T_{J(max.)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





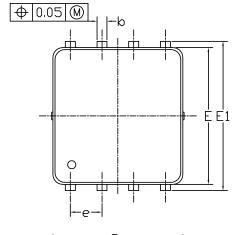
Normalized Thermal Transient Impedance, Junction-to-Ambient

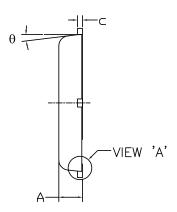


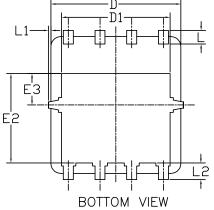
Normalized Thermal Transient Impedance, Junction-to-Case

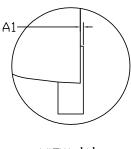


DFN5x6_8L_EP1_P PACKAGE OUTLIN



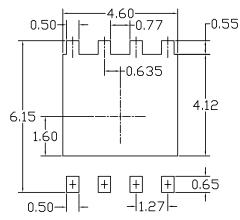






<u>VIEW 'A'</u> (SCALE 5:1)

RECOMMENDED LAND PATTERN



SYMBOLS	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES			
3 I WIBULS	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.85	0. 95	1.00	0.033	0.037	0.039	
A1	0.00		0.05	0.000		0.002	
b	0.30	0.40	0.50	0.012	0.016	0.020	
c	0. 15	0. 20	0. 25	0.006	0.008	0.010	
D	5. 10	5. 20	5. 30	0. 201	0. 205	0. 209	
D1	4. 25	4. 35	4. 45	0. 167	0. 171	0. 175	
Е	5. 45	5. 55	5. 65	0. 215	0. 219	0. 222	
E1	5. 95	6.05	6. 15	0. 234	0. 238	0. 242	
E2	3. 525	3. 625	3. 725	0. 139	0. 143	0. 147	
E3	1. 175	1. 275	1. 375	0.046	0.050	0.054	
e	1. 27 BSC			0.050 BSC			
L	0.45	0. 55	0.65	0.018	0.022	0.026	
L1	0		0. 15	0		0.006	
L2	0.68 REF			0. 027 REF			
θ	0°		10°	0°		10°	

NOTE

- UNIT: mm
- 1. PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS. MOLD FLASH AT THE NON-LEAD SIDES SHOULD BE LESS THAN 6 MILS EACH.
- 2. CONTROLLING DIMENSION IS MILLIMETER. CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.



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